## Search Notes



App	lication	/Control	No
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10748657

Applicant(s)/Patent Under Reexamination

LEE, KYOUNG-JAE

Examiner

Koziol, Stephen R

Art Unit

2624

## **SEARCHED**

Class	Subclass	Date	Examiner
382	319	9/28/2008	SRK
358	488	9/28/2008	SRK

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Search Notes	Date	Examiner
NPL search IEEE explore and INSPEC for pre-scanning methods	9/28/2008	SRK

## **INTERFERENCE SEARCH**

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